

AN6156 Calculating Power Losses in an IGBT Module Application Note

Replaces AN6156-1

Introduction

The Insulated Gate Bipolar Transistor (IGBT) is an active power semiconductor switch which is well suited for high power active front end rectifiers, motor drives, traction drives, converters, wind turbine applications. This application note demonstrates both analytical and simulation-based methods for determining device power losses and junction temperatures for standard topologies

Refer to AN5700 for a complete explanation of Dynex's IGBT naming convention.



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Types of Power Loss

Power losses in IGBTs are comprised primarily of steady – state conduction losses and switching losses. The total average power loss in the IGBT is given by:

 $P_{IGBT(AV)} = P_{cond} + P_{sw}$

Whereas, the Diode is given by the forward conduction losses and reverse recovery losses.

$P_{Diode(AV)} = P_{cond} + P_{rec}$

This application note describes the theory behind the calculation and shows how to calculate the power losses for the IGBT and Diode and the junction temperatures respectively.

In an IGBT module there are many IGBT die and diode die depending on the module and requirements of the application (re Figure 1). All chips dissipate power when they are conducting or switching from one state to another

The conduction losses for the IGBT and freewheeling diode are the product of the current flowing through the collector or anode and saturation voltage (on state voltage) over the conducting period. In contrast, the switching



Figure 1. 190mm x 140mm IGBT Module Layout

losses occur as a result of energy loss during the on/off transition and are function of the switching frequency.

IGBT Power Loss Composition

An IGBT is a voltage-controlled device which combines the advantages of a MOSFET and a BJT. It is a three-terminal device; collector, emitter and gate terminal. It is a four-layer semiconductor that uses the drive characteristics of a MOSFET and voltage characteristics of BJT. For high power IGBT modules it is necessary to provide a suitable heatsink, in order to mitigate thermal runaway.

IGBT losses are comprised of two categories:

-Conduction

-Switching (E_{SW})



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Conduction Losses



Figure 3. IGBT Output Characteristics with onstate parameters

Conduction losses are the losses that occur while the IGBT or freewheeling diode is on and conducting current, the total power dissipation during conduction is computed by multiplying the on-state voltage and the on-state current. In PWM applications the conduction loss must be multiplied by the duty factor to obtain average power dissipation. A first order approximation of conduction losses can be obtained by multiplying the IGBT's rated V_{CESAT} by the expected average device current.

The average conduction loss dissipated by the IGBT is given by the following equation.

$$Pcond(IGBT) = \frac{1}{T} \int_0^T [V_{CE}(t) * I_{CE}(t)] dt$$

In order to connect datasheet values to the above equation; we need to linearize the equation to a more common on-state loss equation seen in several semiconductor devices.

$$Pcond(IGBT) = V_{CE0} * i + R_0 * i^2$$

 $Pcond(Diode) = V_{Do} * i + R_{Do} * i^{2}$ The new linearized equation introduces two new terms:

-V_{CE0}, On-state voltage threshold voltage, temperature dependent

-R₀, On-state resistance, temperature dependent

Figure 3, illustrates how the On-state characteristic terms V_{CE0} and R_0 are obtained; a best practice is to utilise Output Characteristic figure at $T_{VJ(max)}$, as this will use the worst case condition.

Note: Most Dynex switching loss curves utilise $\pm 15V$; therefore, when estimating/calculating V_{CE0} and R₀, use the 15V V_{GE} curve.

The On-state characteristics can be determined by first establishing two points of V_{CE} and Collector Current Ic. Then simply calculate the inverse slope of the Vge = 15V curve.

$$R_0 = \frac{V_{CE2} - V_{CE1}}{I_{C2} - I_{C1}}$$

 V_{CE0} , can be calculated by establishing a line on the Output Characteristics figure (re Figure 3) and determining the X-intercept or by drawing a straight line to the X-axis and verifying a couple points with the following equation:

$$V_{CE(sat)} = V_{CE0} + R_0 * I_C$$

A similar process is done with the IGBTs antiparallel FRD as shown in Figure 4.





Figure 5. Switching waveforms, instantaneous power curve and energy integral (DIM1200ASM45-TF000)

Switching Losses Esw

Switching losses can be the major source of device losses, this is highly dependent on the application's switching frequency. Voltage source inverters, active front end rectifiers and Buck/Boost converters are highly dependent on applied switching frequency; whereas, lower frequency applications, such MMCs are less susceptible to switching losses.

During the transition interval both the current through and the voltage across the device are substantially larger than zero, which leads to large instantaneous power loss. The curves show the simplified current and voltage waveforms and the dissipated power during one switching cycle of an IGBT in an inverter leg.

The integral of the instantaneous power yields the switching energy for one transition at the applied collector current. Most IGBT datasheets express the derived switching energies as a function of collector current.



The FRD's reverse recovery losses are a similar mechanism to the IGBT in which during the FRD turn off period there is a temporary non-zero reverse current and voltage. Dynex datasheets typically depict all incorporated device switching energies on the same curve; however, some devices do have dedicated IGBT and FRD switching energy curves.

The basic principal to determining the switching power loss for an IGBT is with following equation:

$$P_{SW(IGBT)} = (E_{ON} + E_{OFF}) * f_{SW}$$

$$P_{SW(Diode)} = (E_{REC}) * f_{SW}$$

The switching power loss needs to be normalized with the conditions provided for any application with the nominal values from the datasheet.

 $P_{SW(IGBT)} = \frac{(E_{ON} + E_{OFF}) * f_{SW}}{\pi} * \frac{I_{pk}}{I_{NOM}} * \frac{V_{DC \ Link}}{V_{NOM}}$

$$P_{SW(Diode)} = \frac{(E_{REC}) * f_{SW}}{\pi} * \frac{I_{pk}}{I_{NOM}} * \frac{V_{DC \ Link}}{V_{NOM}}$$

fsw =	Switching Frequency
<i>I</i> РК =	Peak collector current
<i>I</i> NOM =	Nominal rated current of device
$V_{\rm DC \ Link} =$	DC Link Voltage
V _{NOM} =	Datasheet dynamic Vline
$E_{ON} =$	Turn on energy loss @ I _{PK}
Eoff =	Turn off energy loss @ I _{PK}
$E_{REC} =$	Diode reverse recovery energy
	loss @ I _{PK}

Total Losses

By determining the switching and conduction losses it is possible to obtain reasonable characterizations of the system's efficiency, thermal load and most importantly the junction temperature of the devices.

$$P_{Total} = P_{Cond(IGBT)} + P_{SW(IGBT)} + P_{Cond(Diode)} + P_{SW(Diode)}$$

The previous equations for switching and conduction losses are general purpose and not suited for specific applications.

ANNEX 1 of this application note contains application analytical common specific equations for the determination of module losses for the following topologies:



-3 Level T Type Converter

-Buck / Boost DC Converter





Figure 8. Thermal circuit for junction temperature estimation

Junction Temperature Estimation

For IGBT modules Figure 8 demonstrates a one-dimensional approximation allowing for the estimation of junction temperature.

A tabulated calculation using a spreadsheet or offline calculation requires the temperature rises be calculated for each junction.

$$T_{j(IGBT)} = \Delta T_{IGBT} + \Delta T_{ch} + \Delta T_{hs} + T_a$$

$$T_{j(Diode)} = \Delta T_{Diode} + \Delta T_{ch} + \Delta T_{hs} + T_{a}$$

IGBT Temp rise:

 $P_{Total(IGBT)} = P_{SW(IGBT)} + P_{Cond(IGBT)}$

$$\Delta T_{j(IGBT)} = R_{TH \ j-c(IGBT)} * (P_{Total(IGBT)})$$

Diode Temp rise:

 $P_{Total(Diode)} = P_{SW(Diode)} + P_{Cond(Diode)}$

$$\Delta T_{j(Diode)} = R_{TH \ j-c(Diode)} * (P_{Total(Diode)})$$

Case – heatsink temp rise:

 $P_{Module} = P_{Total(IGBT)} + P_{Total(Diode)}$

$$\Delta T_{ch} = R_{TH \, c-hs} * P_{Module}$$

Heatsink - temp

 $P_{Heatsink} = P_{Module1} + \dots + P_{ModuleN}$

$$\Delta T_{hs} = R_{TH hs} * P_{Heatsink}$$

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our product properties under your specific operating conditions. Select the converter topology you would like to design.		C 01522 502 901
Choose Converter Topology: 3-Lovel Three Phase (T-Type) 		
		3 Level Three Phase T-Type Converter

Figure 9. Design Tool topology selection page

Simulation Platforms

Utilising the analytical methods described in the previous sections requires considerable effort and time to implement, the analytical methods are suitable for conservative calculations, however, simulation tools offer superior characterization and efficiency.

Dynex offers two simulation methods:

Design Tool PLECS thermal descriptions

Both PLECS thermal models and the Design Tool utilize the same data sets that are contained in published datasheets.

Design Tool

The <u>Design Tool</u> is Dynex's online platform that can offer up to three simultaneous component evaluations for a number of topologies.

Another feature of the Design Tool is interactive data sheets in which two operating points can evaluated on the Switching Energy and Output Characteristics. In the Application Examples section, a Design Tool simulation is provided using the integrated report publisher.



Figure 10. Design Tool interactive datasheet

PLECS Thermal Descriptions

Dynex also provides PLECS thermal descriptions for detailed and bespoke simulations.

Design Tool Application Example

2 Level Converter

Nominal voltage-(V)

DC-Link voltage-(V)

hing frequency-(Hz) 🕐

3700.0

Design A: DIM750ASM65-TF000 Design B: DIM750ASM65-TS000 Design C: DIM750ASM65-TL000

The **Design Tool** is utilized in this example to simultaneously evaluate Dynex's 6500V / 750A IGBT modules in a simple 2 Level Converter. In one simulation a design is capable of determining which 6500V part offering is most suitable for the application. Note: Negative power factor is required for rectifier applications.

minal current-(A)

0.001401

er factor (?) -0.9

Parameters for System Simulation:



tive power ? Inductive **Export Simulation Results to PDF** UPDATE SYSTEM SIMULATION 0 DESIGN A DESIGN B DESIGN C Calculated System Losses 🕐 Overview system losses 201 Design A Design B Design C 15 ន្លឺ10k duction Losse itching Lo nbined Lo Switching Losses-(W) Combined Losses-(W) tion Los в с А в с А в с А System 909.17 787.09 766.05 4342.85 12948.91 19240.16 5252.01 13736.01 20006.21 Switch S1 370.3 298.27 275.36 1718.54 5904.06 9059.38 2088.83 6202.33 9334.75 541.23 Diode D1 83.87 94.93 107.33 436.58 491.43 520.45 586.36 648.56 Switch S2 298.78 1755.18 5995.06 9106.93 2126.14 6293.84 9382.76 370.96 275.83 640.15 532.62 516.59 Diode D2 84.04 95.11 107.53 432.55 558.37 653.49 alculated System Parameters rent P (VA) Efficiency-(%) Grid Voltage-(V) Cu Ma M. А в С А в С 330000.0 98.77 96.83 95.45 1100.0 300.0 163.3 0.89 0.033 0.005 0.001

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Annex 1 – Analytical Loss Equations

Loss Estimation Equation		
Conduction Loss		
Modulation index, $m = \frac{V_{out(pk)}}{0.5*V_{DC(LINK)}}$		
Power factor, typically $cos(\phi)$ inverter = 0.8 to 0.95 & $cos(\phi)$ Rectifier = -0.9 to -0.99		
IGBT conduction losses:		
$V_{CEsat} = V_{CE0} + I.R_0$ where $R_0 = \frac{V_{CE2} - V_{CE1}}{I_{C2} - I_{C1}}$ V _{CE0} – refer to Conduction Losses Section		
Diode conduction losses: $V_F = V_{D0} + I.R_{D0}$ where $R_{D0} = \frac{V_{D02} - V_{D01}}{I_{f2} - I_{f1}}$ V_{D0} – refer to Conduction Losses Section		
IGBT: $P_{cond(l)} = \left(\frac{1}{2\pi} + \frac{m \cdot \cos(\varphi)}{8}\right) * V_{CE0} * I_{pk} + \left(\frac{1}{8} + \frac{m \cdot \cos(\varphi)}{3\pi}\right) * R_0 * I_{pk}^2$		
FRD: $P_{cond(D)} = \left(\frac{1}{2\pi} - \frac{m * \cos(\varphi)}{8}\right) * V_{Do} * I_{pk} + \left(\frac{1}{8} - \frac{m * \cos(\varphi)}{3\pi}\right) * R_{Do} * I_{pk}^2$		
Switching Loss		
IGBT: $P_{SW(I)} = \left(E_{ON(@I_{NOM})} + E_{OFF(@I_{NOM})}\right) * f_{SW} * \frac{\sqrt{2}}{\pi} * \frac{I_{out}}{I_{NOM}} * \frac{V_{DC Link}}{V_{NOM}}$		
FRD: $P_{SW(D)} = (E_{REC(@I_{NOM})}) * f_{SW} * \frac{\sqrt{2}}{\pi} * \frac{I_{out}}{I_{NOM}} * \frac{V_{DC Link}}{V_{NOM}}$ lout = RMS output current hence $I_{Pk} = \sqrt{2} \cdot I_{out}$		





Buck	Conduction
Converter	IGBT: $P_{cond} = \frac{V_{out}}{V_{in}} (I_{out} * V_{CE0} + I_{out}^2 * R_0)$
	Diode: $P_{cond} = \frac{V_{in} - V_{out}}{V_{in}} (I_{out} * V_{Do} + I_{out}^2 * R_{Do})$
	Switching
	IGBT: $P_{SW} = \left(E_{ON(@I_{NOM})} + E_{OFF(@I_{NOM})}\right) * f_{SW} * \frac{I_{out}}{I_{NOM}} * \frac{V_{in}}{V_{NOM}}$
	Diode: $P_{SW} = \left(E_{REC(@NOM)}\right) * f_{SW} * \frac{I_{out}}{I_{NOM}} * \frac{V_{in}}{V_{NOM}}$
Boost	Conduction
Converter ○ ● ● ● ○	IGBT: $P_{cond} = \left(1 - \frac{V_{in}}{V_{out}}\right) (I_{in} * V_{CE0} + I_{in}^2 * R_0)$
	Diode: $P_{cond} = \left(\frac{V_{in}}{V_{out}}\right) (I_{in} * V_{Do} + I_{in}^2 * R_{Do})$
	Switching
	IGBT: $P_{SW} = \left(E_{ON(@I_{NOM})} + E_{OFF(@I_{NOM})}\right) * f_{SW} * \frac{I_{in}}{I_{NOM}} * \frac{V_{out}}{V_{NOM}}$
	Diode: $P_{SW} = \left(E_{REC(@NOM)}\right) * f_{SW} * \frac{I_{in}}{I_{NOM}} * \frac{V_{out}}{V_{NOM}}$

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